

## LVD TEST REPORT

For

# Kaer Technology Co.,Ltd.

### **Terminal**

### **Model:**

SC,JG,GTY,C45,DTG,DTS,OT,DT,DL,GT-G,GL-G,DTL,DTL-2,JG-2,GTL,SC(JGY),SC(JGB),AUS, DIN GTY,DIN DL,JBL,JBT,JB-TL,T/J,CAPG,APG,CCT,CCA,WCJB

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**Report Number:** 

**Date of Test:** 

**Date of Report:** 

TTCF1113-LVD

Nov.16, 2021

Nov.16, 2021



#### TEST REPORT DECLARATION

Applicant : Kaer Technology Co.,Ltd.

Address : No.230, Wei 20th Road, Yueqing Economic Development Zone,

Zhejiang Province, China

Manufacturer : Kaer Technology Co.,Ltd.

Address : No.230, Wei 20th Road, Yueqing Economic Development Zone,

Zhejiang Province, China

EUT Description : Terminal Model No. : SC50-10 Remark : N/A

Test Procedure Used:

EN 60998-1:2004

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The test results of this report relate only to the tested sample identified in this report.

Date of Test : Nov.16, 2021

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Prepared by

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Approved by

(Johnson)





	EN 60998-1:2004		
Clause	Requirement-Test	Result-Remark	Verdict
1	Scope		P
	This part of IEC 60998 applies to connecting		P
	devices as separate entities for the connection of		
	two or more electrical copper conductors		
	(complying with IEC 60228 or IEC 60344) rigid		
	(solid or stranded) or flexible, having a		
	cross-sectional area of 0,2 mm 2 up to and		
	including 35 mm 2 text deleted with a rated		
	voltage not exceeding 1 000 V a.c. up to and		
	including 1 000 Hz and 1 500 V d.c. where		
	electrical energy is used for household and		
	similar purposes.		
2	Normative references		P
	The following referenced documents are		P
	indispensable for the application of this		
	document. For dated references, only the edition		
	cited applies. For undated references, the latest		
	edition of the referenced document (including any		
	amendments) applies.		
3	Terms and definitions		P
	For the purpose of this standard, the following		P
	definitions apply		
4	General		P
	Connecting devices shall be so designed and		P
	constructed that in normal use their performance		
	is reliable and without danger to the user or		
	surroundings. Compliance is checked by carrying out all tests		
	specified.		
5	General notes on tests		P
	5.1 Tests according to this standard are type tests.		P
	5.2 Unless otherwise specified, the samples are		
	tested as delivered and installed as in normal		
	use, at an ambient temperature of 20 °C $\pm$ 5 °C.		
	5.3 The tests are carried out in the order of the clauses.		
	5.4 Unless otherwise stated, three samples are		
	submitted to all the tests and the		
	requirements are satisfied if all the tests are met.		
	If only one of the samples does not satisfy		
	a test due to an assembly or manufacturing fault,		
	that test and any preceding ones which may have influenced the results of the test shall be		
	repeated and also the tests which follow shall be		
	repeated and also the tests which follow shall be		





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Clause	Requirement-Test	Result-Remark	Verdict
	made in the required sequence on another full set		
	of samples, all of which shall comply with		
	the requirements		
6	Main characteristics		P
	6.1 The preferred values of the rated insulation		P
	voltage of the connecting device are 125 V,		
	250 V, 300 V, 400 V, 500 V, 600 V, 690 V, 800 V,		
	1 000 V a.c. and d.c., and 1 500 V d.c		
	6.2 The standard rated connecting capacities are		
	0,2 mm 2 , 0,34 mm 2 , 0,5 mm 2 , 0,75 mm2 ,		
	1 mm 2 , 1,5 mm 2 , 2,5 mm 2 , 4 mm 2 , 6 mm		
	2, 10 mm2, 16 mm 2, 25 mm 2 and 35 mm 2.		
	6.3 Ambient temperatures above 40 °C require T		P
	marking.		
	The preferred values are 55 °C, 85 °C, 110 °C,		
	140 °C and 200 °C. If other values are used,		
7	they shall be multiples of 5 °C. Classification		P
,			
	Connecting devices as separate entities are classified as follows.		P
	7.1 Classification according to the number of		
	terminals		
	- single terminal devices;		
	- multiway terminal devices.		
	7.2 Classification according to function		P
	- junction devices;		
	- tapping devices;		
	<ul> <li>junction and tapping devices.</li> </ul>		
	7.3 Classification according to protection		P
	against electric shock		
	- devices with protection;		
	<ul><li>devices with protection.</li><li>7.4 Classification according to means of fixing</li></ul>		P
	- devices without means of fixing (location is		1
	only ensured by the stiffness of the conductors		
	which are connected to them);		
	- devices with means of fixing (location is		
	ensured by their own fixing means or by		
	associated means, such as screws, rails supports or similar).		
	7.5 Classification according to the maximum		P
	ambient temperature of use of the		r
	connecting device (rated temperature)		
	- devices without T marking for ambient		
	temperatures not higher than 40 °C;		
	- devices with T marking for ambient		
	temperatures higher than 40 °C.		
	7.6 Classification according to protection against		P
	harmful ingress of water and humidity and against solid foreign objects		
	For the description of the IP degrees, see IEC		
	i or the description of the if degrees, see IEC		1





	EN 60998-1:2004		
Clause	Requirement-Test	Result-Remark	Verdict
	60529.		
8	Marking		P
	8.1 The following markings shall be put on the		P
	main part:		
	a) rated connecting capacity in square millimetres (see 6.2 and 8.3);		
	b) rated insulation voltage in volts (if any);		
	c) maximum ambient temperature of use in		
	degrees Celsius if greater than 40 °C, expressed		
	as a T marking (see 6.3 and 8.3);		
	d) type reference (for example, a catalogue number);		
	e) manufacturer's or responsible vendor's name or		
	trade mark or identification mark;		
	f) IP code, if greater than IP20.		
	For very small devices with a surface insufficient		
	for marking, only the markings stated in d) and e) need to be indicated on the device. In such		
	cases all the marks specified shall be visible		
	on the smallest package unit.		
	8.2 For multiway terminal devices the required		P
	marking shall be complete on at least any two		
	adjacent devices.		
	8.3 When symbols are used they shall be as follows	s:	
	V for volts;		
	mm <sup>2</sup> or for rated connecting capacity in squar	a millimetres:	
	T for maximum ambient temperature. For		
		or example, 7 do.	
	© text deleted ©		
	8.4 Marking on the product shall be durable and		P
	easily legible. Compliance with 8.1 to 8.4 is checked by		
	inspection and by the following test on the		
	device.		
	The test is made by rubbing the marking by hand		
	for 15 s with a piece of cloth soaked with		
	water and again for 15 s with a piece of cloth		
	soaked with petroleum spirit. After these tests the		
	marking shall still be legible.		
9	Protection against electric shock		P
	Connecting devices with protection against		P
	electrical shock shall be constructed as specified in the relevant Part 2, such that live parts are not		
	accessible when correctly installed and fitted		
	with an insulated conductor of the smallest and/or		
	largest cross-sections.		
	Each clamping unit of the connecting device shall		
	be connected alternatively with a conductor of the smallest and largest specified cross-section		
	accommodated by the clamping unit.		
	of the smallest and largest specified cross-section, or the minimum and maximum combination		





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Clause	Requirement-Test	Result-Remark	Verdict	
	Compliance is checked unless otherwise specified in the relevant Part 2 by the following test carried out for connecting devices with ancillary parts intended for protection against electric shock.			
	In the case of T-marked products the connecting device is brought to a temperature of $T \pm 2$ °C.			
	The standard test finger, according to IEC 61032, is applied with a force of 10 N to any openings on the connecting device and, if it penetrates fully or partially, it is placed in every possible position. The test probe shall be applied to the connecting device immediately upon removal from the heating cabinet.			
	An extra-low voltage supply (between 40 V and 50 V) in series with a suitable lamp is connected between the test finger and the live parts. Conducting parts covered only with varnish or paint, or protected by oxidation or by a similar process, shall be covered with a metal foil and electrically connected to those parts which are normally live in service. Protection is satisfactory if the lamp does not light.			
10	Connection of conductors		P	
	Connecting devices shall allow the correct connection of conductors, which are specified in the relevant section of the particular requirements of the relevant Part 2.		P	
11	Construction		P	
	11.1 The constructional requirements are given in the relevant Part 2.		Р	
	11.2 Clamping units shall be so designed and constructed that they clamp the conductors reliably and between metal surfaces, with the exception of specific cases subject to requirements of the relevant Part 2. Compliance is checked by inspection and by the relevant test specified in the relevant Part 2.		Р	
	11.3 Connecting devices shall be so designed and constructed that conductors may be installed without the insulation of any one of them being in contact with live parts connected to another conductor of different polarity. Compliance is checked by inspection and, if necessary, by mounting the connecting device with the least favourable conductors or combinations thereof		P	
	11.4 Insulating linings, barriers and the like shall have adequate mechanical strength and shall be secured in a reliable manner.  Compliance is checked by inspection after the		P	





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Clause	Requirement-Test	Result-Remark	Verdict
	tests of Clause 14.		
	11.5 Current-carrying parts, including all		P
	terminals, shall be of a metal having, under the		
	conditions occurring in the equipment,		
	mechanical strength, electrical conductivity and		
	resistance to corrosion adequate for their intended		
	use.		
	Compliance is checked by inspection and, if		
	necessary, by chemical analysis.		
	Examples of suitable metals, when used within a		
	permissible temperature range and under		
	normal conditions of chemical pollution, are:		
	- copper;		
	- an alloy containing at least 58 % copper for		
	parts that are worked cold or at least 50 %		
	copper for other parts;		
	- stainless steel containing at least 13 %		
	chromium and not more than 0,09 % carbon		
	- steel provided with an electroplated coating of		
	zinc according to ISO 2081, the coating		
	having a thickness of at least		
	• 5 µm (ISO service condition 1) for ordinary		
	equipment;		
	• 8 µm (ISO service condition 2) for drip-proof		
	and splash-proof equipment;		
	• 12 µm (ISO service condition 3) for jet-proof		
	and watertight equipment;		
	- steel provided with an electroplated coating		
	of nickel and chromium according to ISO 1456,		
	the coating having a thickness of at least		
	• 10 µm (ISO service condition 1) for ordinary		
	equipment;		
	• 20 µm (ISO service condition 2) for drip-proof		
	and splash-proof equipment;		
	• 30 µm (ISO service condition 3) for jet-proof		
	and watertight equipment;		
	- steel provided with an electroplated coating		
	of tin according to ISO 2093, the coating having		
	a thickness equal to at least that specified for		
	• 12 µm (ISO service condition 1) for ordinary		
	equipment;		
	• 20 μm (ISO service condition 2) for		





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Clause	Requirement-Test	Result-Remark	Verdict
	drip-proof and splash-proof equipment;		
	• 30 µm (ISO service condition 3) for jet-proof		
	and watertight equipment.		
	Current-carrying parts, which may be subjected to		
	mechanical wear, shall not be made of steel		
	provided with an electroplated coating.		
	Under moist conditions, metals showing a large		
	difference of electrochemical potential with		
	respect to each other shall not be used in contact		
	with each other.		
	Compliance will be checked by a test which is		
	under consideration.		
	11.6 Terminals, according to their rated		P
	connecting capacity, shall accept the connection		
	of		
	the number and the cross-sections of rigid (solid		
	or stranded) and flexible conductors of class 5		
	according to IEC 60228, or IEC 60344, text		
	deleted conductors as specified by the		
	manufacturer.		
	Compliance is checked by connecting the		
	appropriate conductors and by inspection		
	11.7 The fixing means of bases shall not serve		P
	any other purpose.		
	Compliance is checked by inspection.		
12	Resistance to ageing, to humidity conditions, to		P
	ingress of solid objects		
	and to harmful ingress of water		
	12.1 Connecting devices shall be resistant to		P
	ageing.		
	Unless otherwise specified in the relevant Part 2,		
	the following test is carried out:		
	Connecting devices with insulating material other		
	than ceramic and thermosetting material are		
	subjected to a test in a heating cabinet with an		
	atmosphere having the composition and		
	pressure of the ambient air and which is		
	ventilated.		
	NOTE 1 The ventilation may be provided by		
	natural circulation through holes in the walls of		
	the heating cabinet.		
	The samples are kept in the cabinet for 7 days		





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Clause	Requirement-Test	Result-Remark	Verdict	
	(168 h) the temperature of which being			
	$(70 \pm 2)$ °C for non-T-marked connecting devices			
	or T + 30 °C $\pm$ 2 °C for T-marked devices (for			
	example, for $T = 85$ the cabinet temperature shall			
	be $115 ^{\circ}\text{C} \pm 2 ^{\circ}\text{C}$ ).			
	NOTE 2 The use of an electrically heated cabinet			
	is recommended.			
	After this treatment, the samples are removed			
	from the cabinet and left at room temperature for			
	at least 4 h.			
	The samples shall show no cracks visible to the			
	naked eye with normal or corrected vision			
	without additional magnification nor shall the			
	material have become sticky or greasy, this being			
	judged as follows.			
	The sample is placed on one of the pans of a			
	balance and the other pan is loaded with a mass			
	equal to the mass of the sample plus 500 g.			
	Equilibrium is then restored by pressing the			
	sample with the forefinger, wrapped in a dry			
	piece of rough cloth.			
	After the test, the samples shall show no damage			
	which would lead to non-compliance with this			
	standard.			
	12.2 Connecting devices shall be designed to		P	
	withstand humid conditions which may occur in			
	normal use.			
	Unless otherwise specified in the relevant Part 2,			
	the following test is carried out.			
	The test is made using the humidity treatment			
	described below immediately followed by the			
	measurement of insulation resistance and the			
	electrical strength test specified in Clause 13.			
	The humidity treatment is carried out in a			
	humidity cabinet containing air with relative			
	humidity			
	maintained between 91 % and 95 %. The			
	temperature of the air, at all places where samples			
	can be located, is maintained within 1 °C of any			
	convenient value of t between 20 °C and			
	30 °C. Before being placed in the humidity			
	cabinet, the samples are brought to a temperature			





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Clause	Requirement-Test	Result-Remark	Verdict
	between t and $t + 4$ °C.		
	The samples are kept in a cabinet for		
	- 168 h for connecting devices where		
	protection against ingress of water as specified in		
	the		
	relevant Part 2 is higher than IPX2;		
	- 48 h for all other products		
	After this test, the samples shall show no damage		
	within the meaning of this standard		
	12.3 The connecting device shall provide an IP		P
	degree of protection against harmful ingress		
	of water in accordance with the classification of		
	the devices.		
	Compliance is checked by the appropriate test		
	according to IEC 60529 which is made on		
	connecting devices fitted with the cables for		
	which they are designed. Immediately after this		
	test the samples shall withstand an electric		
	strength test as specified in 13.4 and an inspection		
	shall show that water has not entered the samples		
	to any appreciable extent and not reached		
	live parts.		
13	Insulation resistance and electric strength		P
	13.1 The insulation resistance and electric		P
	strength of insulated connecting devices shall be		
	adequate.		
	Unless otherwise specified in the relevant Part 2,		
	compliance is checked by the tests of 13.3		
	and 13.4 which are made immediately after the		
	test of 12.2 in the humidity cabinet or in the		
	room in which the samples were brought to the		
	prescribed temperature.		
	13.2 The insulation between the connected		P
	conductors and the external surface of the		
	connecting device shall be adequate for all the		
	combinations of conductors for which the		
	connecting device is designed.		
	Compliance is checked by the test of 13.3.		
	13.3 Each clamping unit of a connecting device		P
	shall be connected alternatively with		
	conductors of the smallest and the largest		
	cross-sectional area.		





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Clause	Requirement-Test	Result-Remark	Verdict
	The insulation resistance is then measured with a		
	d.c. voltage of approximately 500 V applied,		
	the measurement being made 1 min after		
	application of the voltage.		
	The measurements are made consecutively as		
	indicated below:		
	a) between all clamping units connected together		
	and the body for connecting devices without		
	fixing means or between all clamping units		
	connected together and the mounting base for		
	connecting devices with fixing means;		
	b) between each clamping unit and all others		
	connected to the body for connecting devices		
	without fixing means or between each clamping		
	unit and all others connected to the		
	mounting base for connecting devices with fixing		
	means;		
	c) between metal foil in contact with the internal		
	surface of the internal insulating lining of		
	metal enclosures and the body, if this lining is		
	necessary to ensure conformity with the		
	required clearance between live parts and		
	- metal covers and enclosures without		
	insulating lining;		
	- the surface on which the base is mounted.		
	For the measurements according to items a) and		
	b), the metal foil is applied in such a way that		
	the sealing compound, if any, is effectively tested.		
	The insulation resistance shall be not less than 5		
	ΜΩ		
	13.4 The electric strength is tested by applying a		P
	voltage of substantially sine-wave form,		
	having a frequency of 50 Hz or 60 Hz and a value		
	as specified in table 1, for 1 min between the		
	parts listed in 13.3.		
	Initially, not more than half the prescribed voltage		
	is applied, then it is raised rapidly to		
	the full value.		
	No flashover or breakdown shall occur during the		
	test.		
	The overcurrent relay shall not trip when the		
	output current is less than 100 mA.		
	<u> </u>		1





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Clause	Requirement-Test		Result-Rema	rk	Verdict
	Care is taken that the r.m.s. value	of the test			
	voltage applied is measured within $\pm 3$				
	Glow discharges without a drop in	voltage are			
	disregarded				
	Table 1 – Relationship between rated	d insulation v	voltage and test volta	age	
	Rated insulation voltage	Т	est voltage V		
	≤130		1 250		
	>130 and ≤250		2 000		
	>250 and ≤450		2 500		
	>450 and ≤750		3 000 3 500		
	>750		3 500		
14	Mechanical strength				P
	14.1 Connecting devices shall have	ve adequate			P
	mechanical strength. Protective enclose	sures, in			
	particular, shall withstand the stress	ses imposed			
	during installation and use.				
	Unless otherwise specified in the rele	evant Part 2,			
	compliance is checked by the tests of	14.2			
	for connecting devices having a mass	less than 50			
	g or 14.3 for connecting devices havir	ng a			
	mass equal to or greater than 50	g. Tests are			
	carried out without conductors fitted u	ınless			
	otherwise stated in the relevant Part 2				
	14.2 Samples are tested in the tum	bling barrel			P
	according to IEC 60068-2-32.				
	Screws, if any, are tightened wit	h a torque			
	specified in the relevant Part 2.				
	The barrel is turned for a total of 50 fa	alls.			
	After the test, the sample shall show	no damage			
	within the meaning of this standard. In	n			
	particular, the device shall not show	any breaks,			
	cracks or deformation which would pr	-			
	from continuing to maintain live part				
	from ensuring their protection against	-			
	shock.				
	14.3 The samples with insulation are	subjected to			P
	blows by means of the pendular hamn	•			
	according to IEC 60068-2-75.				
	The striking element shall have a mas	ss of 150 g ±			
	1 g.	<i>5</i>			
	Before applying the blows, fixing scre	ews of bases			
1					



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	and covers are tightened with a torque			
	specified in the relevant Part 2.			
	The samples are mounted on the plywood as in			
	normal use so that the point of impact lies in			
	the vertical plane through the axis of the pivot.			
	The striking element is allowed to fall from a			
	height of			
	- 7,5 cm for those parts of covers which are			
	recessed to a depth of at least one-sixth of the			
	largest dimension of the recessed part;			
	- 10 cm for flat surfaces of cover plates of			
	flush-type connecting devices;			
	- 20 cm for parts projected from the mounting			
	surfaces (for example, rims extending 20 mm			
	from the walls) of cover plates of flush-type			
	connecting devices and for enclosures of			
	surface types;			
	- 25 cm for enclosures of any other type.			
	The height of fall is the vertical distance between			
	the position of a checking point, when the			
	pendulum is released and the position of that			
	point at the moment of impact. The checking			
	point is marked on the surface of the striking			
	element where the line through the point of			
	intersection of the axes of the steel tube of the			
	pendulum and the striking element and meets			
	the surface perpendicular to the plane through			
	both axes.			
	The samples are subjected to 10 blows which are			
	evenly distributed over the sample.			
	In general, 5 of the blows are applied as follows:			
	- for flush-type connecting devices, one blow			
	in the centre, one at each extremity of the area			
	over the recess in the block and the other two			
	approximately midway between the previous			
	blows, preferably on the ridge, if any, the sample			
	being moved horizontally;			
	for other connecting devices, one blow in the			
	centre, one on each side of the sample after			
	it has been turned as far as possible but not			
	through more than 60°, about a vertical axis			
	and the other two approximately midway between			





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P





	EN 60998-1:2004		
Clause	Requirement-Test	Result-Remark	Verdict
	the relevant Part 2.		
	15.2 Connecting devices with a single terminal		P
	(see Figure 1) having one or more clamping		
	units shall be connected to conductors in the		
	intended manner and the most unfavourable		
	conditions.		
	Conductor length shall be 1 m for a		
	cross-sectional area up to and including 10 mm 2		
	and 2 m		
	for a cross-sectional area above 10 mm 2.		
	Conductor length may be reduced in agreement		
	with manufacturer.		
	15.3 For multiway terminal devices a maximum		P
	of 3 adjacent terminals are connected in		
	series. If single-pole connecting devices are		
	designed to be mounted side by side, 3 devices		
	are placed in the intended manner and connected		
	together (see Figure 2).		
	Conductor length shall be 1 m for a		
	cross-sectional area up to and including 10 mm2		
	and 2 m		
	for a cross-sectional area above 10 mm 2.		
	Conductor length may be reduced in agreement		
	with manufacturer		
	15.4 The connections are made with new		P
	conductors of the largest cross-sectional area		
	appropriate to the clamping units, the clamping		
	units being connected according to the		
	specifications of the relevant Part 2. For devices		
	with a T marking, measurement shall be made		
	at a temperature equal to the T marking with a		
	tolerance of ±2 °C.		
	Temperature-rise measurements are made when		
	the device under test has reached thermal		
	equilibrium. It is generally accepted that the		
	temperature is stable when the temperature of the		
	part under test does not increase by more than 1		
	K/h. During the whole of the testing the		
	devices are loaded with alternating current having		
	the value shown in Table 2		





	EN 609	998-1:2004			
Clause	Requirement-Test		Result-Rema	rk	Verdict
	Table 2 – Relationship between rated	connecting o	apacity and test curr	rent	
	Rated connecting capacity	Т	est current		
	mm <sup>2</sup>		A		
	0,2		4		
	0,34		5		
	0,5 0,75		9		
	1		13,5		
	1,5		17,5		
	2,5		24		
	4		32		
	6		41		
	10		57		
	16		76		
	25		101		
	35		125		
	The temperature is determined by	means of			P
	colour-changing indicators or thermod	couples, so			
	chosen and positioned that they have	a negligible			
	effect on the temperature being determ	nined			
	(for example, on the metallic part in	contact with			
	the conductor).				
	The temperature rise of current-carry	ing parts of			
	the clamping unit shall not exceed 45	K, it			
	being understood that in the case of	an insulated			
	device the temperature rise of the con-	ductor			
	shall be measured as close as pos				
	clamping unit.				
	The temperature rise measurement in	the case of			
	devices for a rated temperature not				
	exceeding 40 °C is made at 20 °C ±	5 °C. In the			
	case of devices T-marked for higher ra				
	temperature, the temperature rise mea	asurement is			
	made at a temperature equal to the T				
	marking with a tolerance of $\pm 2$ °C.				
16	Resistance to heat				P
	16.1 Connecting devices having	parts in			P
	insulating material shall be sufficiently	-			
	to heat.				
	Unless otherwise specified in the rele	evant Part 2.			
	compliance is checked by the tests of				
	and 16.3.				
	16.2 The samples or portions of the	samples as			P
	process of portions of the	P			





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Clause	Requirement-Test	Result-Remark	Verdict
	specified in the relevant Part 2 are kept for		
	1 h in a heating cabinet at a temperature of 85 °C		
	or a temperature equal to their T rating		
	+45 K, whichever is the higher, with a tolerance		
	of ±5 °C.		
	During the test they shall not undergo any change		
	impairing their further use and the sealing		
	compound, if any, shall not flow to such an extent		
	that live parts are exposed		
	After the test and after the samples have been		
	allowed to cool to approximately ambient		
	temperature, there shall be no access to live parts		
	which are normally not accessible when the		
	samples are mounted as in normal use, even if the		
	standard test finger is applied with a force		
	not exceeding 5 N.		
	After the test, markings shall still be legible		
	16.3 Parts of insulating material necessary to		P
	retain current-carrying parts and parts of the		
	earthing circuit in position are subjected to a		
	ball-pressure test by means of the apparatus		
	according to IEC 60695-10-2.		
	When it is not possible to carry out the test on the		
	sample under test, the test has to be carried		
	out on a plain piece of plastic part cut out from		
	the sample with a minimum thickness of 2 mm.		
	If it is not possible, up to four layers, each cut out		
	from the sample with a minimum total		
	thickness of 2,5 mm, or a sample of material at		
	least 2 mm thick may be used.		
	The surface of the part to be tested is placed in		
	the horizontal position on a base of steel at		
	least 3 mm thick.		
	The test is made in a heating cabinet at a		
	temperature of 125 °C $\pm$ 2 °C or at the T rating		
	plus		
	45 °C, whichever is the higher. After 1 h, the ball		
	is removed from the sample, which is then		
	cooled down within 10 s to approximately		
	ambient temperature by immersion in cold water.		
	The diameter of the impression caused by the ball		
	is measured and shall not exceed 2 mm.		





	EN 609	998-1:2004		
Clause	Requirement-Test		Result-Rema	rk Verdict
	Parts of the insulating material not i	necessary to		
	retain current-carrying parts and parts	of the		
	earthing circuit in position, even thou	igh they are		
	in contact with them, are subjected to	a ball-		
	pressure test as described above	but at a		
	temperature of 70 °C $\pm$ 2° C or 40 °C	± 2 °C, plus		
	the highest temperature rise determi	ned for the		
	relevant part during the test of Clause	15,		
	whichever is the higher.			
17	Clearances and creepage distances			P
	Unless otherwise specified in the rele	evant Part 2,		P
	creepage distances, clearances and			
	distances through sealing compound	shall not be		
	less than the value shown in Table 3.			
	Table 3 – Clearances a	nd creepage	distances	
	Rated insulation voltage	Creepage and	I clearances distances a	1
	V	отобрадо апт	mm	
	≤130		1,5	
	>130 and ≤250		3,0	
	>250 and ≤450		4,0	
	>450 and ≤750		6,0	
	>750		8,0	
	a These values are under consideration.			
	Compliance is checked by measurem	ent hetween		P
	the following parts:	one between		
	Creepage distances and clearances:			
	<ul><li>between live parts of different po</li></ul>	larity:		
	<ul><li>between live parts and</li></ul>	fulley,		
	• metal covers and enclosur	es without		
	insulating lining;	villiout		
	• the surface on which the base is mo	unted		
	Distances through sealing compound:	antou.		
	<ul> <li>between live parts covered w</li> </ul>	vith sealing		
	compound and the surface on which the	•		
	mounted.			
	For multiway terminal devices an	d terminals		
	without fixing means but with			
	distances	r		
	are measured between live parts and	any opening		
	which represents the closest point liab			
	touch any other part when the termi			
	with conductors having the largest cro			
	The conductors having the largest ero	55		





	EN 60998-1:2004		
Clause	Requirement-Test	Result-Remark	Verdict
	sectional area.		
18	Resistance of insulating material to abnormal heat		P
	and fire		
	Unless otherwise specified in the relevant Part 2,		P
	compliance is checked by the glow-wire test.		
	The test is performed according to Clauses 4 to		
	10 of IEC 60695-2-10, under the following		
	conditions:		
	- for parts of insulating material necessary to		
	retain current-carrying parts and parts of the		
	earthing circuit in position, by the test made at a		
	temperature of 850 °C;		
	- for parts of insulating material not necessary		
	to retain current-carrying parts and parts of		
	the earthing circuit in position, even though they		
	are in contact with them and for		
	enclosures retaining in position only earthing		
	clamping units by the test made at a temper-		
	ature of 650 °C.		
	If the tests specified have to be made at more than		
	one place on the same sample, care must		
	be taken to ensure that any deterioration caused		
	by previous tests does not affect the result of		
	the test to be made		
	The glow-wire test is applied to ensure that an		
	electrically heated test wire under defined test		
	conditions does not cause ignition of insulating		
	parts or to ensure that a part of insulating		
	material, which can be ignited by the heated test		
	wire under defined conditions, has a limited		
	time to burn without spreading fire by flame or		
	burning parts or droplets falling from the tested		
	part onto the pinewood board covered with a		
	tissue paper.		
	If possible, the sample shall be a complete		
	connecting device.		
	If the test cannot be made on a complete		
	connecting device, a suitable part may be cut		
	from it		
	for the purpose of the test.		
	The test is made on one sample		
	In case of doubt, the test shall be repeated on two		





	EN 60998-1:2004		
Clause	Requirement-Test	Result-Remark	Verdict
	further samples, both of which shall then		
	pass the test.		
	The test is made applying the glow-wire once for		
	5 s with a tolerance of 01—+s.		
	The sample shall be positioned during the test in		
	the most unfavourable position of its intended		
	use with the surface tested in a vertical position.		
	The tip of the glow-wire shall be applied to the		
	specified surface of the sample taking into		
	account the conditions of the intended use under		
	which a heated or glowing element may come		
	into contact with the sample.		
	The sample is regarded as having passed the		
	glow-wire test if		
	- there is no visible flame and no sustained		
	glowing,		
	or if		
	- flames and glowing on the sample extinguish		
	within 30 s after the removal of the glow-wire.		
	There shall be no ignition of the tissue paper or		
	scorching of the board.		
	In case of doubt, the test shall be repeated on two		
	further samples, which shall then		
	pass the test.		
19	Resistance of insulating material to tracking		P
	Unless otherwise specified parts of insulating		P
	material retaining live parts in position shall be of		
	material resistant to tracking.		
	For materials other than ceramic and where the		
	creepage distances are less than twice the		
	values specified in Clause 17, compliance is		
	checked by the following test on three samples.		
	The test is performed according to IEC 60112.		
	A flat surface of the part to be tested at least 15		
	$mm \times 15 \text{ mm}$ and at least 3 mm thick is placed		
	in the horizontal position on the apparatus.		
	The material under test shall pass at a proof		
	tracking index of 175 V using the test solution A		
	with an interval between drops of 30 s $\pm$ 5 s.		
	In case of doubt, the test shall be repeated on a		
	new set of samples, which shall then pass thetest.		
20	EMC requirements		P



File No.: TTCF1113-LVD

Clause  Requirement-Test Unless otherwise specified in the relevant Part 2, the following requirements for immunity and emission apply  20.1 Immunity The operation of connecting devices within the scope of this standard in normal use is not affected by electromagnetic disturbances.  20.2 Emission Connecting devices within the scope of this standard are intended for continuous use, in normal use they do not generate electromagnetic disturbances  L is 1 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 1 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectiona	EN 60998-1:2004			
the following requirements for immunity and emission apply  20.1 Immunity  The operation of connecting devices within the scope of this standard in normal use is not affected by electromagnetic disturbances.  20.2 Emission  Connecting devices within the scope of this standard are intended for continuous use, in normal use they do not generate electromagnetic disturbances  L is 1 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm²	Clause	Requirement-Test	Result-Remark	Verdict
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20.1 Immunity  The operation of connecting devices within the scope of this standard in normal use is not affected by electromagnetic disturbances.  20.2 Emission  Connecting devices within the scope of this standard are intended for continuous use, in normal use they do not generate electromagnetic disturbances  L is 1 m for a cross-sectional area up to and including 10 mm² L is 2 m for a cross-sectional area above 10 mm²  L is 1 m for a cross-sectional area above 10 mm²  L is 2 m for a cross-sectional area above 10 mm²  L is 2 m for a cross-sectional area above 10 mm²  L is 2 m for a cross-sectional area above 10 mm²  L is 2 m for a cross-sectional area above 10 mm²  L is 2 m for a cross-sectional area above 10 mm²		the following requirements for immunity and		
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Connecting devices within the scope of this standard are intended for continuous use, in normal use they do not generate electromagnetic disturbances  L is 1 m for a cross-sectional area up to and including 10 mm² L is 2 m for a cross-sectional area above 10 mm² Figure 1 – Single terminal device  L is 1 m for a cross-sectional area up to and including 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm² L is 2 m for a cross-sectional area above 10 mm²		affected by electromagnetic disturbances.		
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L is 1 m for a cross-sectional area up to and including 10 mm² L is 2 m for a cross-sectional area above 10 mm²  L is 2 m for a cross-sectional area above 10 mm²		Figure 1 – Single terminal devic	e	
Figure 2 – Multiway terminal device		L is 1 m for a cross-sectional area up to and including 10 mm <sup>2</sup> L is 2 m for a cross-sectional area above 10 mm <sup>2</sup>		
		Figure 2 - Multiway terminal devi	ice	



### **Annex: Technical Information**

## (1) Product Photos





